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Application/Control No.	Applicant(s)/Patent under Reexamination
10/653,199	FUJII, YUKIO
Examiner	Art Unit
Aaron M. Dunwoody	3679

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Class	Subclass	Date	Examiner
updated	search	12/10/2005	Orv
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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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